

<b>Notic of R ferences Cited</b>	Application/Control No. 10/061,384		Applicant(s)/Patent Under Reexamination NGUYEN ET AL.	
	Examiner Mary J. Steelman		Art Unit 2122	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,530,964	06-1996	Alpert et al.	717/158
*	B	US-6,684,298 B1	01-2004	Dwarkadas et al.	711/128
*	C	US-2002/0199178 A1	12-2002	Hobbs et al.	717/150
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U	Badawy, Abdel-Hameed A; Aggarwal, Aneesh; Yeung, Donald; Tseng, Chau-Wen, "Evaluating the Impact of Memory System Performance on Software Prefetching and Locality Optimizations", p. 486-500, ACM 2001, retrieved 01/06/2005.			
	V	Pyo, Changwoo; Lee, Kyung-Woo; Han, Hye-Kyung; Lee, Gyungho; "Reference Distance as a Metric for Data Locality", p. 151-156, 1997 IEEE, retrieved 01/06/2005.			
	W	Shahrier, Sharif M; Liu, Jyn-Charn; "On Predictability and Optimization of Multiprogrammed Caches for Real-Time Applications", p. 17-25 1997 IEEE, retrieved 01/06/2005.			
	X	Xia, Chun; Torrellas, Josep; "Instruction Prefetching of Systems Codes with Layout Optimized for Reduced Cache Misses", p. 271-282, 1996 ACM, retrieved 01/06/2005.			

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.